							F	REVISI	ONS										
LTR		DESCRIPTION									DATE (YR-MO-DA)			APPROVED					
A	Chan	iges in	accorda	ance with I	NOR 5962-	R262-9	2. – sb	r				92-07-16				M. A. Frye			
В	Chan	Changes in accordance with NOR 5962-R065-93. – drw						w		93-01-11			M. A. Frye						
С	Revis	Revise for 'D' certification. Editorial changes throughout dr						ıt. – drv	/				99-1	0-01		Raymond Monnin			
D	Upda	Update to current requirements. Editorial changes through						ughout.	– drw				04-0	)2-18		F	Raymon	d Monr	nin
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MICROCIRCUIT DRAWING					Raymon	d Monn	in					http	)://ww	w.ds	cc.dl	a.mil			
				APPRO	VED BY														
THIS DRAWING IS AVAILABLE FOR USE BY ALL DEPARTMENTS		BLE		Michae	l A. Fry	е		MIC DRI	ROC VER	IRCU , MO	JIT, L NOLI	INEA THIC	R, A SILI	ND P CON	ERIP	HER	ΑL		
AND AGEN	ICIES (	OF THE		DRAWI	NG APPR	OVAL D	ATE												
DEPARTMENT OF DEFENSE			SE		89-0	)4-28													
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DSCC FORM 2233 APR 97

DISTRIBUTION STATEMENT A. Approved for public release; distribution is unlimited.

1. SCOPE
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1.1 <u>Scope</u>. This drawing describes device requirements for MIL-STD-883 compliant, non-JAN class level B microcircuits in accordance with MIL-PRF-38535, appendix A.

1.2 Part or Identifying Number (PIN). The complete PIN is as shown in the following example:

5962-88631 01   Drawing number Device ty (see 1.2)			-				
1.2.1 <u>Device type</u> . The device type ident	, , , , , , , , , , , , , , , , , , ,	, , , , , , , , , , , , , , , , , , ,					
Device type	<u>Generic number</u>		Circuit function				
01	DS1631		Dual AND peripheral driver, CMOS compatible, open collector				
1.2.2 Case outlines. The case outlines a	ire as designated in M	IL-STD-1835 and	as follows:				
Outline letter Descriptive	designator	Terminals	Package style				
_	CY1-X8 3 or CDIP2-T8	8 8	Can Dual-in-line				
1.2.3 Lead finish. The lead finish is as s	pecified in MIL-PRF-3	8535, appendix A.					
1.3 Absolute maximum ratings.							
Supply voltage (V <sub>CC</sub> ) Input voltage (V <sub>IN</sub> ) Output voltage Storage temperature range Maximum power dissipation: <u>1</u> / Case G Case P Lead temperature (soldering, 10 sec Thermal resistance, junction-to-case Junction temperature (T <sub>J</sub> ) 1.4 <u>Recommended operating conditions</u> Case operating temperature range ( Operating supply voltage range (V <sub>CC</sub> )	onds) (θ <sub>J</sub> c) Γc)		-0.3 V dc to V <sub>CC</sub> +0.3 V dc 56 V dc -65°C to +150°C 787 mW 1133 mW +260°C See MIL-STD-1835 +175°C				
<u>1</u> / For case P, derate 7.6 mW/°C above	+25°C; for case G, de		bove +25°C.				
STANDARD MICROCIRCUIT DRAW	ING	SIZE A		5962-88631			
DEFENSE SUPPLY CENTER CO COLUMBUS, OHIO 43216-4	LUMBUS		REVISION LEVEL D	SHEET 2			
DSCC FORM 2234							

### 2. APPLICABLE DOCUMENTS

2.1 <u>Government specification, standards, and handbooks</u>. The following specification, standards, and handbooks form a part of this drawing to the extent specified herein. Unless otherwise specified, the issues of these documents are those listed in the issue of the Department of Defense Index of Specifications and Standards (DoDISS) and supplement thereto, cited in the solicitation.

#### SPECIFICATION

#### DEPARTMENT OF DEFENSE

MIL-PRF-38535 - Integrated Circuits, Manufacturing, General Specification for.

### STANDARDS

### DEPARTMENT OF DEFENSE

MIL-STD-883	-	Test Method Standard Microcircuits.
MIL-STD-1835	-	Interface Standard Electronic Component Case Outlines.

#### HANDBOOKS

### DEPARTMENT OF DEFENSE

MIL-HDBK-103 -	List of Standard Microcircuit Drawings.
MIL-HDBK-780 -	Standard Microcircuit Drawings.

(Unless otherwise indicated, copies of the specification, standards, and handbooks are available from the Standardization Document Order Desk, 700 Robbins Avenue, Building 4D, Philadelphia, PA 19111-5094.)

2.2 <u>Order of precedence</u>. In the event of a conflict between the text of this drawing and the references cited herein, the text of this drawing takes precedence. Nothing in this document, however, supersedes applicable laws and regulations unless a specific exemption has been obtained.

### 3. REQUIREMENTS

3.1 <u>Item requirements</u>. The individual item requirements shall be in accordance with MIL-PRF-38535, appendix A for non-JAN class level B devices and as specified herein. Product built to this drawing that is produced by a Qualified Manufacturer Listing (QML) certified and qualified manufacturer or a manufacturer who has been granted transitional certification to MIL-PRF-38535 may be processed as QML product in accordance with the manufacturers approved program plan and qualifying activity approval in accordance with MIL-PRF-38535. This QML flow as documented in the Quality Management (QM) plan may make modifications to the requirements herein. These modifications shall not affect form, fit, or function of the device. These modifications shall not affect the PIN as described herein. A "Q" or "QML" certification mark in accordance with MIL-PRF-38535 is required to identify when the QML flow option is used. This drawing has been modified to allow the manufacturer to use the alternate die/fabrication requirements of paragraph A.3.2.2 of MIL-PRF-38535 or other alternative approved by the qualifying activity.

STANDARD MICROCIRCUIT DRAWING	SIZE A		5962-88631
DEFENSE SUPPLY CENTER COLUMBUS		REVISION LEVEL	SHEET
COLUMBUS, OHIO 43216-5000		D	3

3.2 <u>Design, construction, and physical dimensions</u>. The design, construction, and physical dimensions shall be as specified in MIL-PRF-38535, appendix A and herein.

3.2.1 <u>Case outlines</u>. The case outlines shall be in accordance with 1.2.2 herein.

3.2.2 <u>Terminal connections</u>. The terminal connections shall be as specified on figure 1.

3.2.3 <u>Truth table</u>. The truth table shall be as specified on figure 2.

3.2.4 Test circuits and switching waveforms. The test circuits and switching waveforms shall be as specified on figure 3.

3.3 <u>Electrical performance characteristics</u>. Unless otherwise specified herein, the electrical performance characteristics are as specified in table I and shall apply over the full case operating temperature range.

3.4 <u>Electrical test requirements</u>. The electrical test requirements shall be the subgroups specified in table II. The electrical tests for each subgroup are described in table I.

3.5 <u>Marking</u>. Marking shall be in accordance with MIL-PRF-38535, appendix A. The part shall be marked with the PIN listed in 1.2 herein. In addition, the manufacturer's PIN may also be marked as listed in MIL-HDBK-103 (see 6.6 herein). For packages where marking of the entire SMD PIN number is not feasible due to space limitations, the manufacturer has the option of not marking the "5962-" on the device.

3.5.1 <u>Certification/compliance mark</u>. A compliance indicator "C" shall be marked on all non-JAN devices built in compliance to MIL-PRF-38535, appendix A. The compliance indicator "C" shall be replaced with a "Q" or "QML" certification mark in accordance with MIL-PRF-38535 to identify when the QML flow option is used. For product built in accordance with A.3.2.2 of MIL-PRF-38535, or as modified in the manufacturer's QM plan, the "QD" certification mark shall be used in place of the "Q" or "QML" certification mark.

3.6 <u>Certificate of compliance</u>. A certificate of compliance shall be required from a manufacturer in order to be listed as an approved source of supply in MIL-HDBK-103 (see 6.6 herein). The certificate of compliance submitted to DSCC-VA prior to listing as an approved source of supply shall affirm that the manufacturer's product meets the requirements of MIL-PRF-38535, appendix A and the requirements herein.

3.7 <u>Certificate of conformance</u>. A certificate of conformance as required in MIL-PRF-38535, appendix A shall be provided with each lot of microcircuits delivered to this drawing.

3.8 <u>Notification of change</u>. Notification of change to DSCC-VA shall be required in accordance with MIL-PRF-38535, appendix A.

3.9 <u>Verification and review</u>. DSCC, DSCC's agent, and the acquiring activity retain the option to review the manufacturer's facility and applicable required documentation. Offshore documentation shall be made available onshore at the option of the reviewer.

STANDARD MICROCIRCUIT DRAWING	SIZE A		5962-88631
DEFENSE SUPPLY CENTER COLUMBUS COLUMBUS, OHIO 43216-5000		REVISION LEVEL D	SHEET <b>4</b>

	-	TABLE I. Electrical performance cha	aracteristics. 1	<u>i/</u>			
Test	Symbol	$\begin{array}{c} \mbox{Conditions} \\ -55^{\circ}\mbox{C} \leq T_{C} \leq +125^{\circ}\mbox{C} \\ \mbox{unless otherwise specified} \end{array}$	Group A subgroups	Device type	Limits		Unit
					Min	Max	<u> </u>
High level input voltage	VIH	$V_{CC}$ = 5 V, See figure 3	1, 2, 3	01	3.5		V
	T	$V_{CC}$ = 10 V, See figure 3			8.0		I
		$V_{CC}$ = 15 V, See figure 3			12.5		
Low level input voltage	VIL	$V_{CC} = 5 V$ , See figure 3	1, 2, 3	01		1.5	V
		$V_{CC}$ = 10 V, See figure 3				2.0	1
		$V_{CC}$ = 15 V, See figure 3	<u> </u>			2.5	ı ———
High level output current	Іон	$V_{IN} = 15 \text{ V} \text{ (all inputs)},$ $V_{CC} = 15 \text{ V}, V_{OUT} = 54 \text{ V}$ See figure 3	1, 2, 3	01		250	μΑ
Low level output voltage	V <sub>OL</sub>	$V_{\text{IN}} = 1.5 \text{ V}, \text{ other inputs} = 4.5 \text{ V}$ $V_{\text{CC}} = 4.5 \text{ V}, \text{ I}_{\text{OL}} = 100 \text{ mA}$ See figure 3	1, 2, 3	01		1.1	V
		$V_{IN} = 1.5$ V, other inputs = 4.5 V $V_{CC} = 4.5$ V, $I_{OL} = 300$ mA See figure 3				1.4	
High level input current	liH	$V_{IN} = 15 \text{ V}, V_{CC} = 15 \text{ V},$ Other input of driver = 0.0 V See figure 3	1, 2, 3	01		10	μΑ
Low level input current	IIL.	$V_{IN} = 0.4 \text{ V}, V_{CC} = 15 \text{ V},$ Other input of driver = 15 V See figure 3	1, 2, 3	01		-360	μΑ
		$V_{IN} = 0.4 V$ , $V_{CC} = 5 V$ , Other input of driver = 5 V, See figure 3				-115.5	
High level breakdown voltage	V <sub>OH</sub>	$V_{CC}$ = 15 V, $I_{OH}$ = 250 µA See figure 3	1, 2, 3	01	56		V
Functional tests		See 4.3.1c	7, 8	01			ı <u> </u>

See footnotes at end of table.

STANDARD MICROCIRCUIT DRAWING	SIZE A		5962-88631
DEFENSE SUPPLY CENTER COLUMBUS		REVISION LEVEL	SHEET
COLUMBUS, OHIO 43216-5000		D	5

TABLE I. <u>Electrical performance characteristics</u> - continued. <u>1</u> /								
Test	Symbol	$\begin{tabular}{lllllllllllllllllllllllllllllllllll$	Group A subgroups	Device type	Lin	nits	Unit	
					Min	Max		
Power supply current	I <sub>CCH</sub>	$V_{IN} = 5 V$ (all inputs),	1, 2, 3	01		3	mA	
		$V_{CC} = 5 V$ , See figure 3						
		V <sub>IN</sub> = 15 V (all inputs),				10		
		$V_{CC}$ = 15 V, See figure 3						
	I <sub>CCL</sub>	$V_{IN} = 0 V$ (all inputs),				11		
		$V_{CC} = 5 V$ , See figure 3						
		$V_{IN} = 0 V$ (all inputs),				20		
		$V_{CC}$ = 15 V, See figure 3						
Propagation delay time	t <sub>PHL</sub>	$V_{CC} = 5 V, C_L = 15 pF,$	9	01	.01	1.50	μS	
		$V_L$ = 10 V, $R_L$ = 50 $\Omega$ or	10, 11	]	.01	1.88		
	t <sub>PLH</sub>	equivalent, See figure 3	9	]	.01	1.20		
		<u>2</u> /	10, 11	]	.01	1.50		

TABLE L Electrical performance characteristics - continued 1/

1/2 Power dissipation must be externally controlled at elevated temperatures (+25°C and +125°C). 2/2 The limits specified for subgroups 10 and 11 are guaranteed but not tested.

Case	
outlines	G and P
Terminal	
number	Pin
1	A1
2	B1
3	X1
4	GND
5	X2
6	A2
7	B2
8	V <sub>cc</sub>

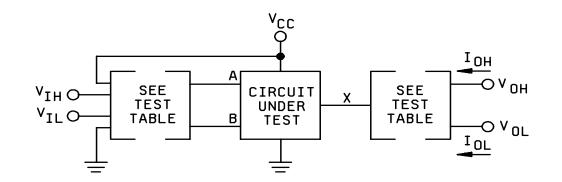
Inpu	Output	
А	В	Х
L	L	L
L	Н	L
н	L	L
Н	Н	Н

FIGURE 2. Truth table.

FIGURE 1. Terminal connections.

# STANDARD **MICROCIRCUIT DRAWING** DEFENSE SUPPLY CENTER COLUMBUS COLUMBUS, OHIO 43216-5000

SIZE <b>A</b>		5962-88631
	REVISION LEVEL D	SHEET 6



Test table

Input under test	Other input	Output		
		Apply	Measure	
V <sub>IH</sub>	VIH	I <sub>OH</sub>	Vон	
VIL	Vcc	I <sub>OL</sub>	V <sub>OL</sub>	

 $V_{IH}, V_{IL},$  test.

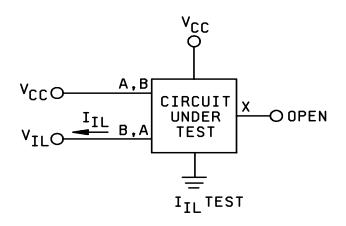
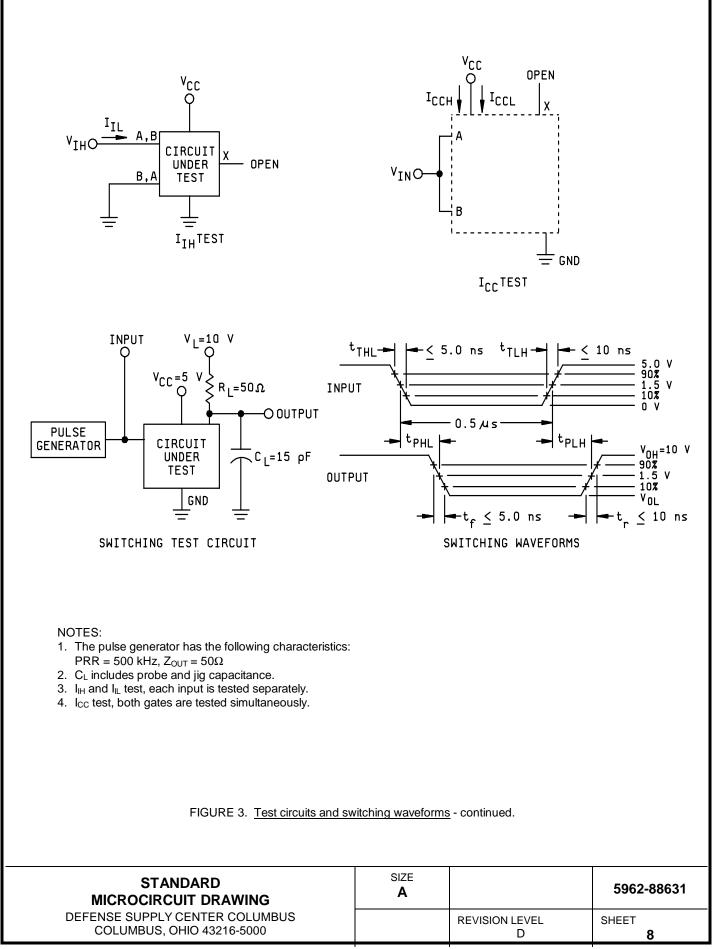


FIGURE 3. Test circuits and switching waveforms.

STANDARD MICROCIRCUIT DRAWING	SIZE A		5962-88631
DEFENSE SUPPLY CENTER COLUMBUS COLUMBUS, OHIO 43216-5000		REVISION LEVEL D	SHEET 7



# 4. QUALITY ASSURANCE PROVISIONS

4.1 <u>Sampling and inspection</u>. Sampling and inspection procedures shall be in accordance with MIL-PRF-38535, appendix A.

4.2 <u>Screening</u>. Screening shall be in accordance with method 5004 of MIL-STD-883, and shall be conducted on all devices prior to quality conformance inspection. The following additional criteria shall apply:

- a. Burn-in test, method 1015 of MIL-STD-883.
  - (1) Test condition A, B, C, or D. The test circuit shall be maintained by the manufacturer under document revision level control and shall be made available to the preparing or acquiring activity upon request. The test circuit shall specify the inputs, outputs, biases, and power dissipation, as applicable, in accordance with the intent specified in test method 1015 of MIL-STD-883.
  - (2)  $T_A = +125^{\circ}C$ , minimum.
- b. Interim and final electrical test parameters shall be as specified in table II herein, except interim electrical parameter tests prior to burn-in are optional at the discretion of the manufacturer.

	Subgroups	
MIL-STD-883 test requirements	(in accordance with	
MIL-OID-000 test requirements	MIL-STD-883, method 5005,	
	table I)	
Interim electrical parameters		
(method 5004)	1	
Final electrical test parameters	1*, 2, 3, 9	
(method 5004)		
Group A test requirements		
(method 5005)	1, 2, 3, 7, 8, 9, 10, 11	
Groups C and D end-point		
electrical parameters	1, 2, 3	
(method 5005)		

### TABLE II. Electrical test requirements.

\* PDA applies to subgroup 1.

4.3 <u>Quality conformance inspection</u>. Quality conformance inspection shall be in accordance with method 5005 of MIL-STD-883 including groups A, B, C, and D inspections. The following additional criteria shall apply.

## 4.3.1 Group A inspection.

- a. Tests shall be as specified in table II herein.
- b. Subgroups 4, 5, and 6 in table I, method 5005 of MIL-STD-883 shall be omitted.
- c. Subgroups 7 and 8 shall include verification of the truth table.

STANDARD MICROCIRCUIT DRAWING	SIZE A		5962-88631
DEFENSE SUPPLY CENTER COLUMBUS		REVISION LEVEL	SHEET
COLUMBUS, OHIO 43216-5000		D	9

## 4.3.2 Groups C and D inspections.

- a. End-point electrical parameters shall be as specified in table II herein.
- b. Steady-state life test conditions, method 1005 of MIL-STD-883.
  - (1) Test condition A, B, C, or D. The test circuit shall be maintained by the manufacturer under document revision level control and shall be made available to the preparing or acquiring activity upon request. The test circuit shall specify the inputs, outputs, biases, and power dissipation, as applicable, in accordance with the intent specified in test method 1005 of MIL-STD-883.
  - (2)  $T_A = +125^{\circ}C$ , minimum.
  - (3) Test duration: 1,000 hours, except as permitted by method 1005 of MIL-STD-883.

# 5. PACKAGING

5.1 Packaging requirements. The requirements for packaging shall be in accordance with MIL-PRF-38535, appendix A.

## 6. NOTES

6.1 <u>Intended use</u>. Microcircuits conforming to this drawing are intended for use for Government microcircuit applications (original equipment), design applications, and logistics purposes.

6.2 <u>Replaceability</u>. Microcircuits covered by this drawing will replace the same generic device covered by a contractor-prepared specification or drawing.

6.3 <u>Configuration control of SMD's</u>. All proposed changes to existing SMD's will be coordinated with the users of record for the individual documents. This coordination will be accomplished using DD Form 1692, Engineering Change Proposal.

6.4 <u>Record of users</u>. Military and industrial users shall inform Defense Supply Center Columbus when a system application requires configuration control and the applicable SMD. DSCC will maintain a record of users and this list will be used for coordination and distribution of changes to the drawings. Users of drawings covering microelectronics devices (FSC 5962) should contact DSCC-VA, telephone (614) 692-0544.

6.5 <u>Comments</u>. Comments on this drawing should be directed to DSCC-VA, Columbus, Ohio 43216-5000, or telephone (614) 692-0547.

6.6 <u>Approved sources of supply</u>. Approved sources of supply are listed in MIL-HDBK-103. The vendors listed in MIL-HDBK-103 have agreed to this drawing and a certificate of compliance (see 3.6 herein) has been submitted to and accepted by DSCC-VA.

STANDARD MICROCIRCUIT DRAWING	SIZE A		5962-88631
DEFENSE SUPPLY CENTER COLUMBUS COLUMBUS, OHIO 43216-5000		REVISION LEVEL D	SHEET 10

### STANDARD MICROCIRCUIT DRAWING BULLETIN

### DATE: 04-02-18

Approved sources of supply for SMD 5962-88631 are listed below for immediate acquisition information only and shall be added to MIL-HDBK-103 and QML-38535 during the next revision. MIL-HDBK-103 and QML-38535 will be revised to include the addition or deletion of sources. The vendors listed below have agreed to this drawing and a certificate of compliance has been submitted to and accepted by DSCC-VA. This bulletin is superseded by the next dated revision of MIL-HDBK-103 and QML-38535.

Otan dand	Mandan	Manadan
Standard	Vendor	Vendor
microcircuit drawing	CAGE	similar
PIN <u>1</u> /	number	PIN <u>2</u> /
5962-8863101GA	3V146	DS1631H/883
5962-8863101PA	3V146	DS1631J-8/883
	<u>3</u> /	AS1631C8/883C

- 1/ The lead finish shown for each PIN representing a hermetic package is the most readily available from the manufacturer listed for that part. If the desired lead finish is not listed contact the vendor to determine its availability.
- <u>2</u>/ <u>Caution</u>. Do not use this number for item acquisition. Items acquired to this number may not satisfy the performance requirements of this drawing.
- $\underline{3}$ / Not available from an approved source.

Vendor CAGE number Vendor name and address

3V146

Rochester Electronics 10 Malcolm Hoyt Drive Newburyport, MA 01950

The information contained herein is disseminated for convenience only and the Government assumes no liability whatsoever for any inaccuracies in the information bulletin.